



Docket No.: SON-2313  
(PATENT)

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

In re Patent Application of:  
Satoshi Ikeda

Application No.: 10/052,736

Confirmation No.: 3283

Filed: January 23, 2002

Art Unit: 2138

For: SEMICONDUCTOR TESTING APPARATUS  
AND METHOD

Examiner: J. C. Kerveros

**NOTICE OF APPEAL**

MS Appeal Brief - Patents  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Dear Sir:

Applicant hereby appeals to the Board of Patent Appeals and Interferences from the Office Action dated February 7, 2007 of the Examiner rejecting claims 3 and 6-32.

The Office Action of February 7, 2007 *reopened* prosecution prior to a decision on the merits by the Board of Patent Appeals and Interferences. Accordingly, please apply the fee paid on March 30, 2005 for the Notice of Appeal. M.P.E.P. §1204.01.

**No additional fee** to the Patent and Trademark Office for this Notice of Appeal is believed to be required. But if any fee is required or any overpayment made, the Commissioner is hereby authorized to charge the fee or credit the overpayment to Deposit Account # 18-0013.

Dated: April 12, 2007

Respectfully submitted,

By  47,255

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